

<b>Notice of References Cited</b>	Application/Control No. 10/629,709	Applicant(s)/Patent Under Reexamination WATANABE, HITOSHI	
	Examiner Thierry L. Pham	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0002072	01-2003	Berkema et al.	358/1.15
*	B	US-2007/0139526	06-2007	Parulski et al.	348/207.99
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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